Ordering number:4660A

PNP Epitaxial Planar Silicon Transistor

2SA1883

High-Speed Switching Applications

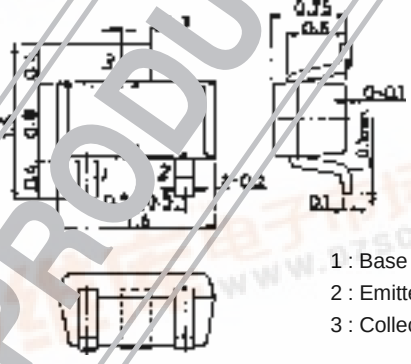
Features

- Fast switching speed.
- Low collector saturatio voltage.
- High gain-bandwidth product.
- Small collector capacitance.
- Very small-sized package permitting 2SA1883-applied sets to be made small and slim.
- Complementary pair with the 2SC4987.

Package Dimensions

unit:mm

2106A



1 : Base
2 : Emitter
3 : Collector

SANYO : SMCP

Specifications

Absolute Maximum Ratings at Ta = 25˚C

Parameter	Symbol	Conditions	Ratings	Unit
Collector-to-Base Voltage	V_{CBO}		–15	V
Collector-to-Emitter Voltage	V_{CEO}		–15	V
Emitter-to-Base Voltage	V_{EBO}		–5	V
Collector Current	I_C		–200	mA
Collector Current (Pulse)	I_{CP}		–500	mA
Base Current	I_B		–40	mA
Collector Dissipation	P_C		150	mW
Junction Temperature	Tj		150	˚C
Storage Temperature	Tstg		–55 to +150	˚C

Electrical Characteristics at Ta = 25˚C

Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector Cutoff Current	I_{CBO}	V_{CB}=–8V, I_E=0			–0.1	μA
Emitter Cutoff Current	I_{EBO}	V_{EB}=–3V, I_C=0			–0.1	μA
DC Current Gain	h_{FE}	V_{CE}=–1V, I_C=–10mA	50	80	140	
Gain-Bandwidth Product	f_T*	V_{CE}=–10V, I_C=–10mA	450	1000		MHz
Output Capacitance	C_{ob}*	V_{CB}=–5V, f=1MHz		1.8	3.0	pF
Collector-to-Emitter Saturation Voltage	$V_{CE(sat)}$	I_C=–10mA, I_B=–1mA		–0.07	–0.20	V
Base-to-Emitter Saturation Voltage	$V_{BE(sat)}$	I_C=–10mA, I_B=–1mA		–0.80	–0.90	V

SANYO Electric Co.,Ltd. Semiconductor Bussiness Headquaters
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Parameter	Symbol	Conditions	Ratings			Unit
			min	typ	max	
Collector-to-Base Breakdown Voltage	$V_{(BR)CBO}$	I_C=–10μA, I_E=0	–15			V
Collector-to-Emitter Breakdown Voltage	$V_{(BR)CEO}$	I_C=–1mA, R_{BE}=∞	–15			V
Emitter-to-Base Breakdown Voltage	$V_{(BR)EBO}$	I_E=–10μA, I_C=0	–5			V
Turn-ON Time	t_{on}	See specified Test Circuit.		11		ns
Storage Time	t_{stg}	See specified Test Circuit.		21		ns
Turn-OFF Time	t_{off}	See specified Test Circuit.		19		ns

Marking : HA

Switching Time Test Circuit